



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10050831</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>AOKI ET AL.</p>
	<p>Examiner</p> <p>Nguyen, Jennifer T</p>	<p>Art Unit</p> <p>2629</p>


Class	SubClass	Date	Examiner
345	78,89,98,100,204,211-214,690	7/7/06	JN

U.S. Patent and Trademark Office	Part of Paper No.:
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<b>Interference Searched</b>  	Application/Control No.  10050831	Applicant(s)/Patent Under Reexamination  AOKI ET AL.
	Examiner Nguyen, Jennifer T	Art Unit 2629

Class	SubClass	Date	Examiner
713	300	7/7/06	JN
348	725	7/7/06	JN

U.S. Patent and Trademark Office	Part of Paper No.:
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<b>Search Notes</b>  	Application/Control No.  10050831	Applicant(s)/Patent Under Reexamination  AOKI ET AL.
	Examiner Nguyen, Jennifer T	Art Unit 2629

Notes	Date	Examiner
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East search, PAJ	7/7/06	JN
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